


<b>Search Notes</b> 	<b>Application/Control No.</b> 10586561	<b>Applicant(s)/Patent Under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> Benny Lee	<b>Art Unit</b> 2817

SEARCHED			
Class	Subclass	Date	Examiner
333	239, 241, 242, 21R	4 January 2010	BTL
343	786	6 January 2010	BTL
29	600	7 January 2010	BTL

SEARCH NOTES			
Search Notes		Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--